IGBT MODULE Spec.No.IGBT-SP-06008 R3 1

MBL400E33D

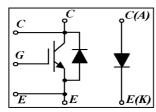
Preliminary SPEC.

Silicon N-channel IGBT

FEATURES

- * High thermal fatigue durability.(delta Tc=70°C,N>30,000cycles)
- * High speed, low loss IGBT module.
- * Low noise due to built-in free-wheeling diode ultra soft fast recovery diode(USFD).
- * Low driving power due to low input capacitance MOS gate.
- * High reliability, high durability module.
- * Isolated heat sink (terminal to base).

CIRCUIT DIAGRAM



ABSOLUTE MAXIMUM RATINGS (TC=25°C)

Unit in mm 57 57 6-47 4-M8 4-M8

Weight: 900(g)

OUTLINE DRAWING

Item		Symbol	Unit	MBL400E33D	
Collector Emitter Voltage		Vces	V	3,300	
Gate Emitter Voltage		VGES	V	±20	
Collector Current		DC	Ic	Α	400
Collector Current	50llector Current 1		ICp	Α	800
Forward Current		DC	lF	^	400
Forward Current	1ms		Iғм	Α	800
Junction Temperature		Tj	°C	-40 ∼ +125	
Storage Temperature		Tstg	°C	-40 ∼ +125	
Isolation Voltage		Viso	VRMS	6,000(AC 1 minute)	
Screw Torque	Terminals (M4/M8)		1	N∙m	2/22 (1)
	Mounting (M6)		-		6 (2)

Notes: (1) Recommended Value 1.8±0.2/22±1N·m

(2) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARECTERISTICS 1) IGBT + FWD

Iter	Symbol	Unit	Min.	Тур.	Max.	Test Conditions	
Collector Emitter Cut-Off Current		ICES	mA	-	-	12.0	VCE=3,300V, VGE=0V, Tj=25°C
Gate Emitter Leakage Current		Iges	nA	-	-	±500	VGE=±20V, VCE=0V, Tj=25°C
Collector Emitter Saturation Voltage		VCE(sat)	V	3.5	4.2	5.0	IC=400A, VGE=15V, Tj=125°C
Gate Emitter Threshold Voltage		VGE(TO)	٧	4.5	6.0	7.0	VCE=10V, IC=400mA, Tj=25°C
Input Capacitance		Cies	nF	-	35	-	VCE=10V, VGE=0V,f=100kHz, Tj=25°C
Internal Gate Resistance		Rge	Ω	-	3.6	-	
Cuitabing Times	Rise Time	tr	μs	1.0	1.9	3.1	Vcc=1,650V, Ic=400A
	Turn On Time	ton		1.5	2.4	0.0	L=150nH
Switching Times	Fall Time	tf		0.5	1.0	2.5	$R_{G=10\Omega}$ (3)
	Turn Off Time	toff		2.0	3.0	5.1	VGE=±15V, Tj=125°C
Peak Forward Voltage Drop		VFM	V	2.0	2.5	3.0	-IC=400A, VGE=0V, Tj=125°C
Reverse Recovery Time		trr	μs	-	0.6	-	Vcc=1,650V, IF=400A (4) L=150nH, Tj=125°C
Thermal Impedance	IGBT	Rth(j-c)	K/W	-	-	0.026	Junction to case
	FWD	Rth(j-c)		-	-	0.052	

2) DIODE

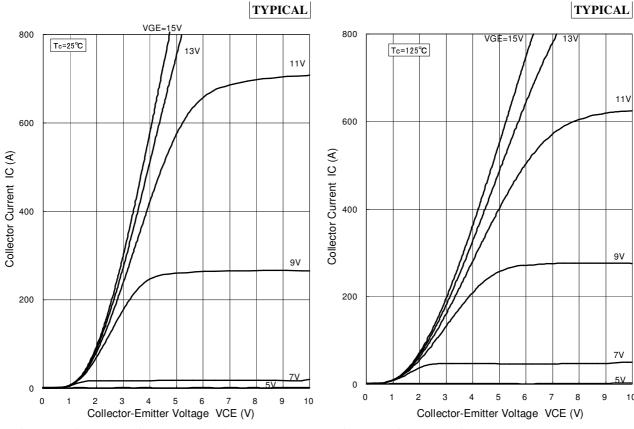
Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions
Collector Emitter Cut-Off Current	IAKS	mA	-	-	12.0	VAK=3,300V, Tj=25°C
Peak Forward Voltage Drop	VF	٧	2.2	2.7	3.2	IF=400A, Tj=125°C At Main terminal (Terminal resistance:0.5mΩ typical)
Reverse Recovery Time	trr	μs	0.2	0.6	1.1	IF =400A, VCC=1,650V (4) L=150nH, Tj=125°C
Thermal Impedance	Rth(j-c)	K/W			0.052	Junction to case

Notes: (3) R_G value is the test condition's value for decision of the switching times, not recommended value. Please, determine the suitable R_G value after the measurement of switching waveforms(overshoot voltage,etc.)with appliance mounted. (4)Counter arm IGBT VGE=-15V



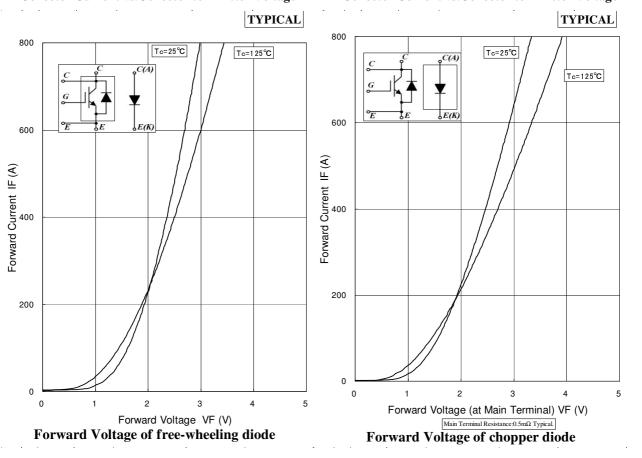
CHARACTERISTICS CURVE

STATIC CHARACTERISTICS

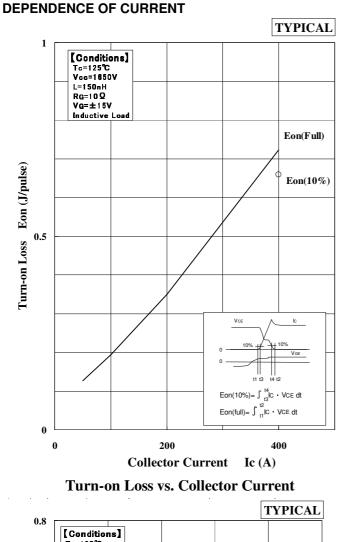


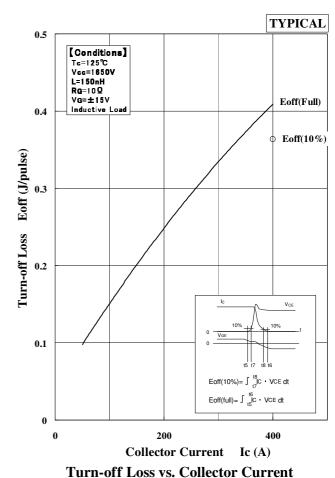
Collector Current vs.Collector to Emitter Voltage

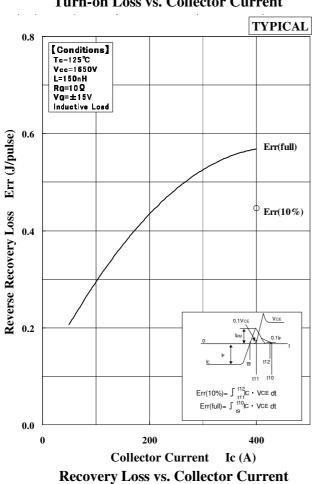










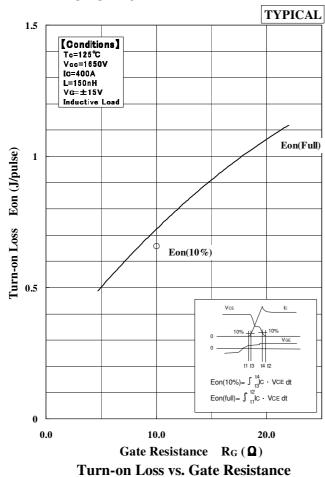


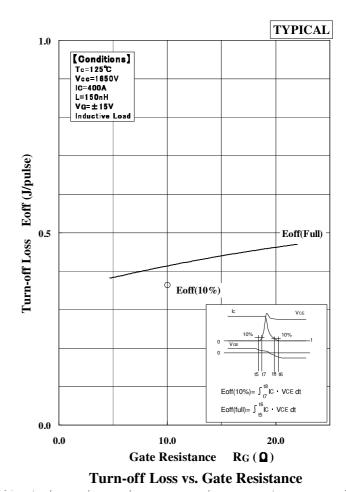
TYPICAL 4.0 [Conditions] To=125°C Vcc=1650V L=150nH RG=10Ω VG=±15V Inductive Load Switching Time ton,tr,toff,tf,trr (μs) toff ton 2.0 tr 1.0 tf trr 0.0 Collector Current IC (A)

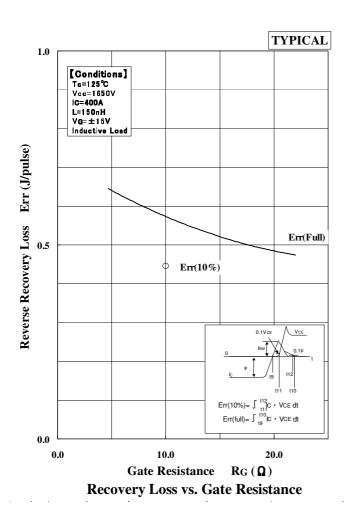
Switching Time vs. Collector Current

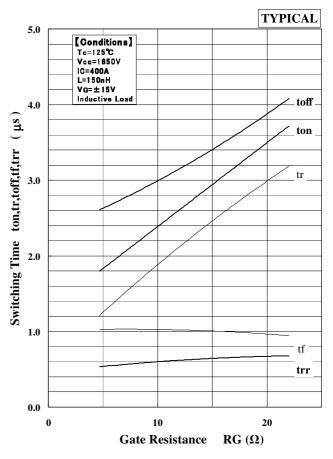


DEPENDENCE OF RG



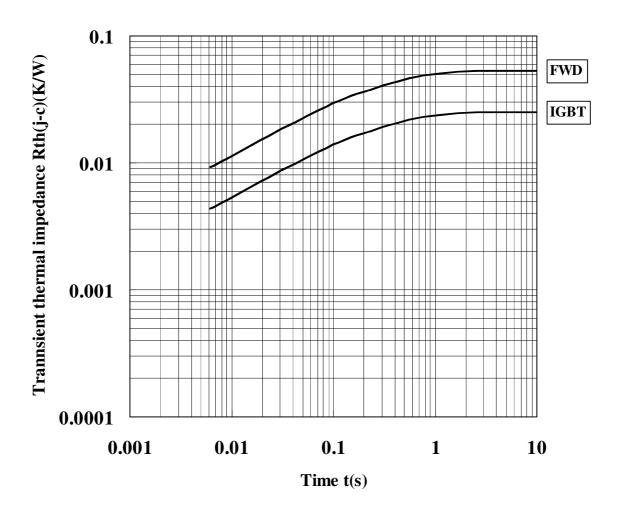






Switching Time vs. Gate Resistance





Transient Thermal Impedance Curve (Maximum Value)

Negative environmental impact material

Please note the following negative environmental impact materials are contained in the product in order to keep product characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder
Arsenic and its compounds	Si chip



HITACHI POWER SEMICONDUCTORS

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